

Notice of References Cited	Application/Control No. 10/772,417	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Christopher E. Mahoney	Art Unit 2851	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0117212	06-2005	Kumagai et al.	359/457
*	B	US-5,066,099	11-1991	Yoshida et al.	359/457
*	C	US-5,513,036	04-1996	Watanabe et al.	359/457
*	D	US-6,124,969	09-2000	Funazaki et al.	359/456
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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